

**Search Notes**

Application/Control No.

10/621,006

Examiner

Benjamin P. Blumel

Applicant(s)/Patent under  
Reexamination

DAVIDSON ET AL.

Art Unit

1648

**SEARCHED**

Class	Subclass	Date	Examiner

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
STIC searched SEQ ID NO:1 and 12			

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	5/22/2007	BPB
Pubmed	5/22/2007	BPB